

<b>Notice of References Cited</b>	Application/Control No. 10/050,162	Applicant(s)/Patent Under Reexamination YAMATO ET AL.	
	Examiner David R. O'Steen	Art Unit 2623	Page 1 of 1

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*	B	US-6,971,119	11-2005	Arsenault et al.	725/89
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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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